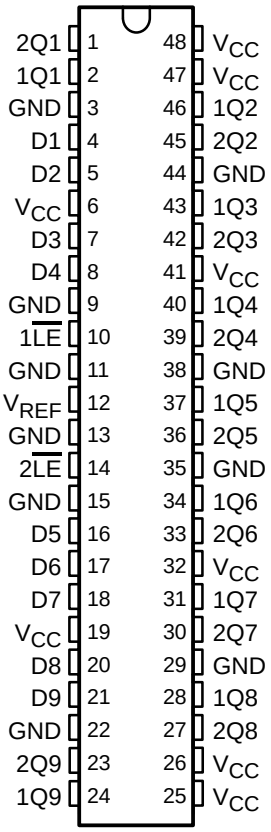
- **Member of Texas Instruments' Widebus™ Family**
- **Inputs Meet JEDEC HSTL Std JESD 8-6, and Outputs Meet Level III Specifications**
- **10-kΩ Pullup Resistor on Data and $\overline{LE}$ Inputs**
- **Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II**
- **ESD Protection Exceeds JESD 22**
  - **2000-V Human-Body Model (A114-A)**
  - **200-V Machine Model (A115-A)**
  - **1000-V Charged-Device Model (C101)**

DGG PACKAGE
(TOP VIEW)



description

This 9-bit to 18-bit D-type latch is designed for 3.15-V to 3.45-V V_{CC} operation. The D inputs accept HSTL levels and the Q outputs provide LVTTL levels.

The SN74HSTL16919 is particularly suitable for driving an address bus to two banks of memory. Each bank of nine outputs is controlled with its own latch-enable ($\overline{LE}$) input.

Each of the nine D inputs is tied to the inputs of two D-type latches that provide true data (Q) at the outputs. While $\overline{LE}$ is low, the Q outputs of the corresponding nine latches follow the D inputs. When $\overline{LE}$ is taken high, the Q outputs are latched at the levels set up at the D inputs.

To ensure low I_{CC} during power up or power down, 10-kΩ pullup resistors are included on the D and $\overline{LE}$ inputs to ensure a differential voltage relative to V_{REF}. V_{REF} must be applied prior to or at the same time as V_{CC}, or V_{REF} must be pulled down to ground.

ORDERING INFORMATION

T_A	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	TSSOP – DGG	Tape and reel	SN74HSTL16919DGGR	HSTL16919

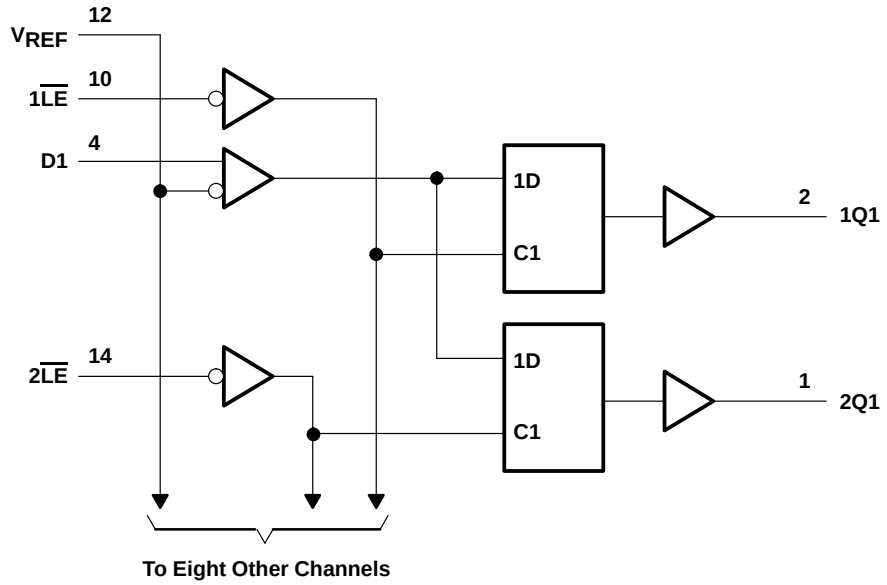
† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

INPUTS		OUTPUT
$\overline{LE}$	D	Q
L	H	H
L	L	L
H	X	Q_0†

† Output level before the indicated steady-state input conditions were established

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V_{CC} . . . . . –0.5 V to 4.6 V
Input voltage range, V_I (see Note 1) . . . . . –0.5 V to V_{CC} + 0.5 V
Output voltage range, V_O (see Note 1) . . . . . –0.5 V to V_{CC} + 0.5 V
Input clamp current, I_{IK} (V_I < 0) . . . . . –50 mA
Output clamp current, I_{OK} (V_O < 0 or V_O > V_{CC}) . . . . . ±50 mA
Continuous output current, I_O (V_O = 0 to V_{CC}) . . . . . ±50 mA
Continuous current through each V_{CC} or GND . . . . . ±100 mA
Package thermal impedance, θ_{JA} (see Note 2) . . . . . 89°C/W
Storage temperature range, T_{stg} . . . . . –65°C to 150°C

‡ Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

			MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage		3.15		3.45	V
V_{REF}	Reference voltage		0.68	0.75	0.9	V
V_I	Input voltage		0		1.5	V
V_{IH}	AC high-level input voltage	All inputs	V_{REF}+200 mV			V
V_{IL}	AC low-level input voltage	All inputs			V_{REF}–200 mV	V
V_{IH}	DC high-level input voltage	All inputs	V_{REF}+100 mV			V
V_{IL}	DC low-level input voltage	All inputs			V_{REF}–100 mV	V
I_{OH}	High-level output current				–24	mA
I_{OL}	Low-level output current				24	mA
T_A	Operating free-air temperature		0		70	°C

NOTE 3: All unused inputs of the device must maintain a minimum differential voltage of 100 mV between data inputs and V_{REF} to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}		V_{CC} = 3.15 V,	I_I = –18 mA			–1.2	V
V_{OH}		V_{CC} = 3.15 V,	I_{OH} = –24 mA	2.4			V
V_{OL}		V_{CC} = 3.15 V,	I_{OL} = 24 mA			0.5	V
I_I	Control inputs	V_{CC} = 3.45 V	V_I = 0 or 1.5 V			–500	μA
	Data inputs		V_I = 0 or 1.5 V			–500	
	V_{REF}		V_{REF} = 0.68 V or 0.9 V			90	
I_{CC}		V_{CC} = 3.45 V,	V_I = 0 or 1.5 V		50	100	mA
C_i	Control inputs	V_{CC} = 0 or 3.3 V,	V_I = 0 or 3.3 V		2.5		pF
	Data inputs	V_{CC} = 0 or 3.3 V,	V_I = 0 or 3.3 V		2.5		
C_o	Outputs	V_{CC} = 0,	V_O = 0		2.5		pF

† All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			V_{CC} = 3.3 V ± 0.15 V		UNIT
			MIN	MAX	
t_w	Pulse duration, $\overline{LE}$ low		3		ns
t_{su}	Setup time, D before $\overline{LE}\uparrow$		2		ns
t_h	Hold time	D after $\overline{LE}\uparrow$	1		ns
t_{ldr}‡	Data race condition time	D after $\overline{LE}\downarrow$		0	ns

‡ This is the maximum time after $\overline{LE}$ switches low that the data input can return to the latched state from the opposite state without producing a glitch on the output.

switching characteristics over recommended operating free-air temperature range, V_{REF} = 0.75 V

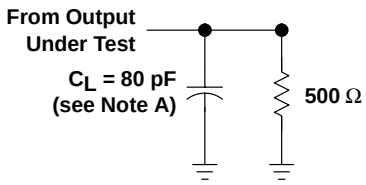
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 3.3 V ± 0.15 V		UNIT
			MIN	MAX	
t_{pd}	D	Q	1.9	3.5	ns
	$\overline{LE}$		1.9	4.3	

simultaneous switching characteristics over recommended operating free-air temperature range, V_{REF} = 0.75 V†

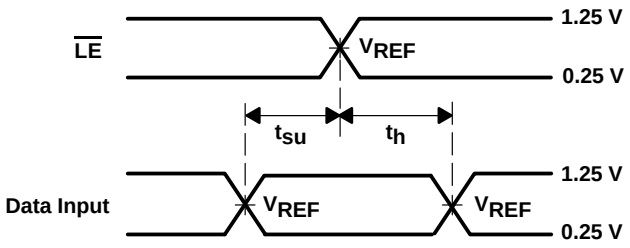
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 3.3 V ± 0.15 V		UNIT
			MIN	MAX	
t_{pd}	D	Q	1.9	4.5	ns
	$\overline{LE}$		1.9	5.3	

† All outputs switching.

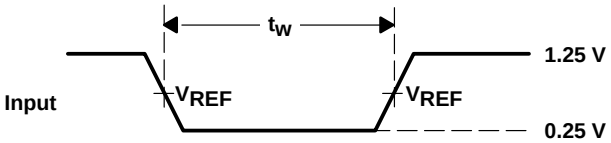
PARAMETER MEASUREMENT INFORMATION



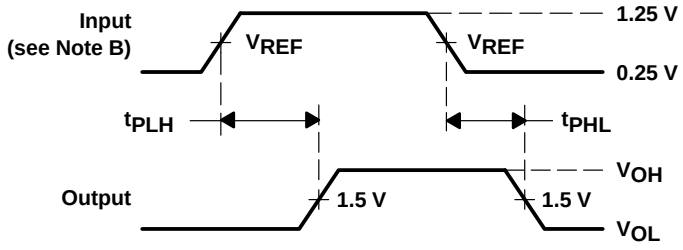
LOAD CIRCUIT



VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PULSE DURATION



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES

NOTES: A. C_L includes probe and jig capacitance.
B. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r ≤ 1 ns, t_f ≤ 1 ns.
C. The outputs are measured one at a time with one transition per measurement.
D. t_{PHL} and t_{PLH} are the same as t_{pd}.

Figure 1. Load Circuit and Voltage Waveforms

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